Application/Control No. Applicant(s)/Patent Under Reexamination 10/814,537 EDIE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Krystyna Suchecki 2882 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,195,112 03-1993 Vincent et al. Α 378/10 * US-4,958,365 В 09-1990 Sohval et al. 378/122 С US-D US-US-Ε US-F US-G Н US-US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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